TOSHIBA

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π -MOSVI)

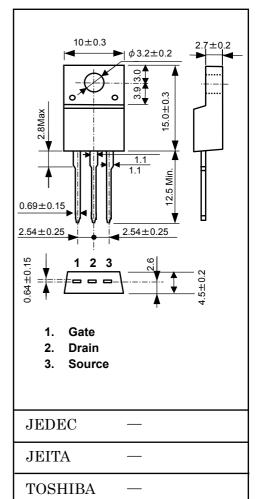
2SK3561

Switching Regulator Applications

- Low drain-source ON resistance: $RDS(ON) = 0.75 \Omega$ (typ.)
- High forward transfer admittance: $|Y_{fs}| = 6.5S$ (typ.)
- Low leakage current: $I_{DSS} = 100 \ \mu A (V_{DS} = 500 \text{ V})$
- Enhancement-mode: $V_{th} = 2.0 \sim 4.0 \text{ V} (V_{DS} = 10 \text{ V}, \text{ID} = 1 \text{ mA})$

Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit
Drain-source voltage		V _{DSS}	500	V
Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)		V _{DGR}	500	V
Gate-source voltage		V _{GSS}	±30	V
Drain current	DC (Note 1)	ID	8	
	Pulse (t = 1 ms) (Note 1)	I _{DP}	32	A
Drain power dissipati	on (Tc = 25°C)	PD	40	W
Single pulse avalanche energy (Note 2)		E _{AS}	312	mJ
Avalanche current		I _{AR}	8	А
Repetitive avalanche energy (Note 3)		E _{AR}	4	mJ
Channel temperature		T _{ch}	150	°C
Storage temperature range		T _{stg}	-55~150	°C



Thermal Characteristics

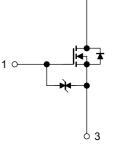
Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	3.125	°C/W
Thermal resistance, channel to ambient	R _{th (ch-a)}	62.5	°C/W

Note 1: Please use devices on conditions that the channel temperature is below 150°C.

Note 2: $V_{DD} = 90 \text{ V}, \text{ T}_{ch} = 25^{\circ}\text{C}(\text{initial}), \text{ L} = 8.3 \text{ mH}, \text{ I}_{AR} = 8 \text{ A}, \text{ R}_{G} = 25 \Omega$

Note 3: Repetitive rating: Pulse width limited by maximum channel temperature

This transistor is an electrostatic sensitive device. Please handle with caution.



φ **2**

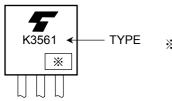
Electrical Characteristics (Ta = 25°C)

Chara	acteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I _{GSS}	$V_{GS}=\pm 25~V,~V_{DS}=0~V$	_		±10	μA
Gate-source brea	akdown voltage	V (BR) GSS	$I_D=\pm 10~\mu A,~V_{GS}=0~V$	±30	_		V
Drain cut-off curr	ent	I _{DSS}	$V_{DS} = 500 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$		_	100	μA
Drain-source bre	akdown voltage	V (BR) DSS	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	500	_		V
Gate threshold ve	oltage	V _{th}	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 1 \text{ mA}$	2.0	_	4.0	V
Drain-source ON	resistance	R _{DS (ON)}	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 4 \text{ A}$		0.75	0.85	Ω
Forward transfer	admittance	Y _{fs}	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 4 \text{ A}$	3.0	6.5	_	S
Input capacitance		C _{iss}	V _{DS} = 25 V, V _{GS} = 0 V, f = 1 MHz		1050	_	pF
Reverse transfer capacitance		C _{rss}		_	10	_	
Output capacitance		C _{oss}			110	_	
Switching time	Rise time	tr	$V_{GS} \\ 0 \\ V \\ 50 \\ \Omega \\ M \\ M$	_	26	_	
	Turn-on time	t _{on}		_	45	_	
	Fall time	t _f			38		ns
	Turn-off time	t _{off}	Duty \leq 1%, t _w = 10 μ s	_	130		
Total gate charge		Qg		_	28	_	
Gate-source charge		Q _{gs}	$V_{DD} \simeq 400 \text{ V}, \text{ V}_{GS} = 10 \text{ V}, \text{ I}_{D} = 8 \text{ A}$	_	16	_	nC
Gate-drain charge		Q _{gd}			12		

Source-Drain Ratings and Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	—	_	_	8	А
Pulse drain reverse current (Note 1)	I _{DRP}	—	_	_	32	А
Forward voltage (diode)	V _{DSF}	I _{DR} = 8 A, V _{GS} = 0 V	_	_	-1.7	V
Reverse recovery time	t _{rr}	$I_{DR} = 8 \text{ A}, V_{GS} = 0 \text{ V},$	_	1200	_	ns
Reverse recovery charge	Q _{rr}	dl _{DR} /dt = 100 A/μs	_	10	_	μC

Marking



※ Lot Number



Month (Starting from Alphabet A) Year (Last Number of the Christian Era)

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